

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination BEIERLE, FRED P.	
		Examiner Jennifer A. Leung	Art Unit 1764	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,104,419	04-1992	Funk, Harald F.	48/209
*	B	US-4,883,499	11-1989	Beierle et al.	48/203
*	C	US-4,530,702	07-1985	Fetters et al.	48/209
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000152799 A	06-2000	Japan	MATSUNAGA, AKIRA	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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